

# SANYO Semiconductors DATA SHEET

#### N-Channel Silicon MOSFET

# **EFC4615R** — General-Purpose Switching Device Applications

#### **Features**

- 2.5V drive
- · Best suited for LiB charging and discharging switch
- · Common-drain type

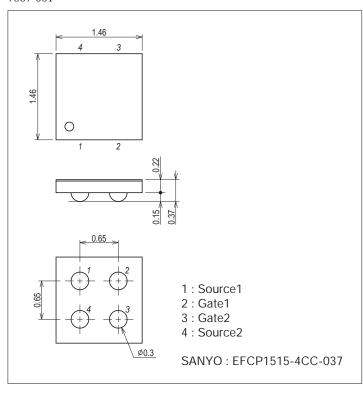
## **Specifications**

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Source-to-Source Voltage	V <sub>SSS</sub>		24	V
Gate-to-Source Voltage	VGSS		±12	V
Source Current (DC)	IS		6	Α
Source Current (Pulse)	ISP	PW≤10μs, duty cycle≤1%	60	Α
Total Dissipation	PT	When mounted on ceramic substrate (5000mm <sup>2</sup> x0.8mm)	1.6	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### **Package Dimensions**

unit : mm (typ) 7067-001



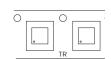
#### **Product & Package Information**

• Package : EFCP

• JEITA, JEDEC :-

• Minimum Packing Quantity : 5,000 pcs./reel

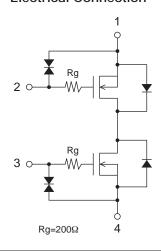
#### Taping Type: TR



#### Marking



#### **Electrical Connection**

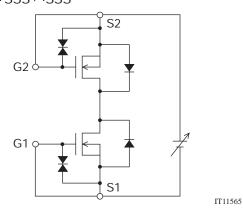


#### Electrical Characteristics at Ta=25°C

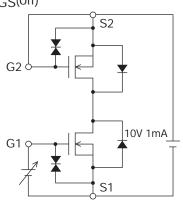
Parameter	Symbol	Conditions		Ratings			Linit
Parameter				min	typ	max	Unit
Source-to-Source Breakdown Voltage	V(BR)SSS	IS=1mA, VGS=0V	Test Circuit 1	24			V
Zero-Gate Voltage Source Current	ISSS	V <sub>SS</sub> =20V, V <sub>GS</sub> =0V	Test Circuit 1			1	μΑ
Gate-to-Source Leakage Current	IGSS	VGS=±8V, VSS=0V	Test Circuit 2			±10	μΑ
Cutoff Voltage	VGS(off)	V <sub>SS</sub> =10V, I <sub>S</sub> =1mA	Test Circuit 3	0.5		1.3	V
Forward Transfer Admittance	yfs	Vss=10V, Is=3A	Test Circuit 4		5.4		S
Static Source-to-Source On-State Resistance	RSS(on)1	I <sub>S</sub> =3A, V <sub>GS</sub> =4.5V	Test Circuit 5	19	27	31	$m\Omega$
	RSS(on)2	I <sub>S</sub> =3A, V <sub>GS</sub> =4.0V	Test Circuit 5	21	28	33	$m\Omega$
	Rss(on)3	I <sub>S</sub> =3A, V <sub>GS</sub> =3.1V	Test Circuit 5	24	33	44	mΩ
	RSS(on)4	IS=3A, VGS=2.5V	Test Circuit 5	28	39	52	$m\Omega$
Turn-ON Delay Time	t <sub>d</sub> (on)	See specified Test Circuit.	Test Circuit 7		13		ns
Rise Time	t <sub>r</sub>	See specified Test Circuit.	Test Circuit 7		235		ns
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit.	Test Circuit 7		335		ns
Fall Time	tf	See specified Test Circuit.	Test Circuit 7		360		ns
Total Gate Charge	Qg	VSS=10V, VGS=4.5V, IS=6A			8.8		nC
Forward Source-to-Source Voltage	V <sub>F</sub> (S-S)	I <sub>S</sub> =6A, V <sub>GS</sub> =0V	Test Circuit 6		1	1.2	V

### Test circuits are example of measuring FET1 side



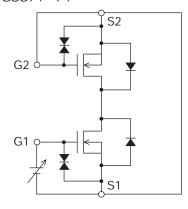


Test Circuit 3 VGS(off)



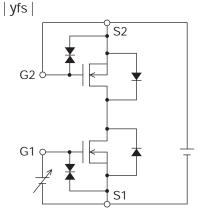
IT11567

Test Circuit 2 IGSS(+) / (--)

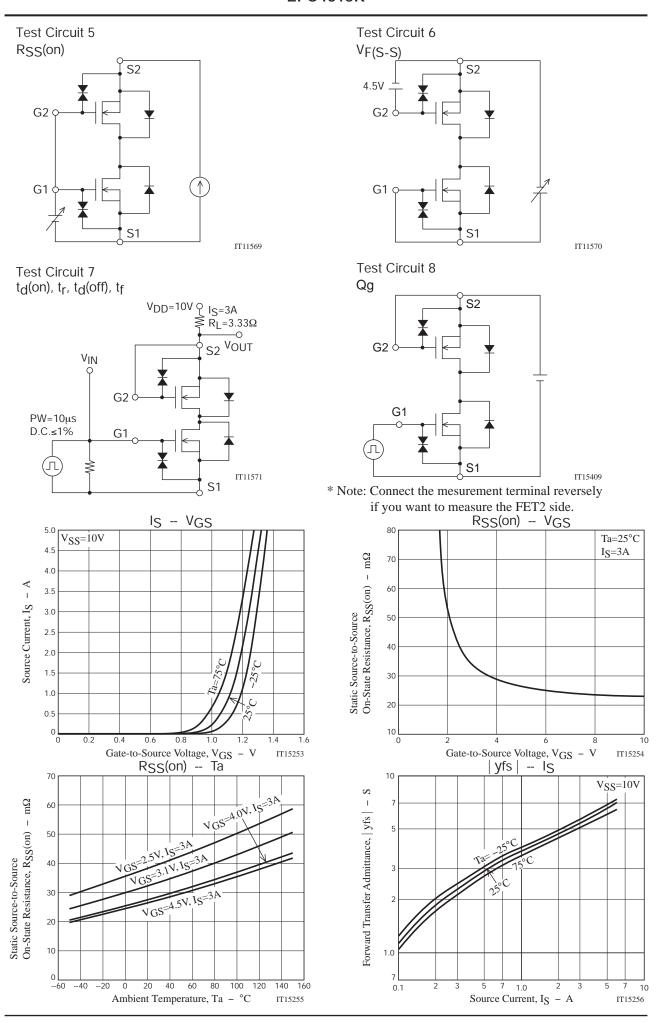


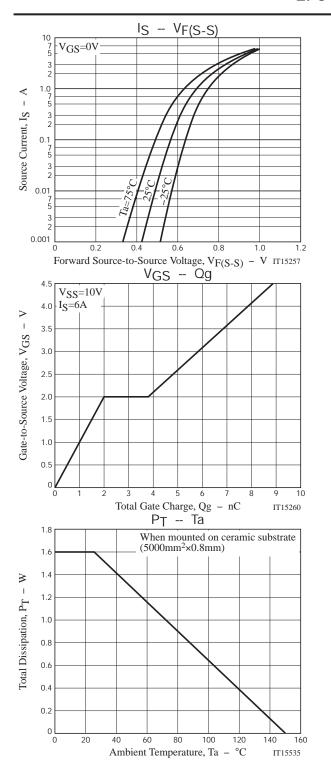
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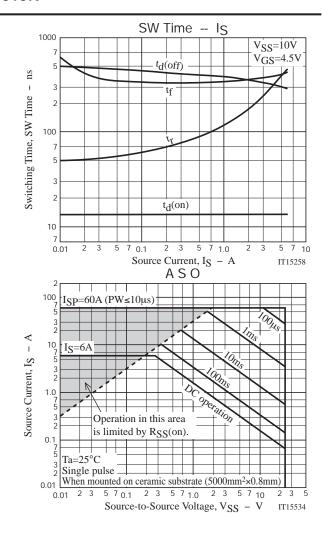
Test Circuit 4



\* Note: Connect the mesurement terminal reversely if you want to measure the FET2 side.







Note on usage: Since the EFC4615R is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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